

EMC TEST REPORT Kyocera Wireless Corp. TRI-MODE CELLULAR MOBILE PHONE

Model: **KX160B** RADIATED EMISSIONS

FCC, PART 2.1053 FCC, PART 22 SUBPART H FCC, PART 24 SUBPART E INDUSTRY CANADA, RSS-129 INDUSTRY CANADA, RSS-133

Test Report # 2005 080713 KX160B FCC

25-713-KYO

NEMKO USA, INC. 11696 SORRENTO VALLEY ROAD SUITE F SAN DIEGO, CA 92121 PHONE: 858-755-5525

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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	2 of31

TABLE OF CONTENTS

1. DESCRIPTION OF TESTING METHODS	7
2. Test Results	14

TEST SETUP DIAGRAMS

FIGURE 1.	GENERAL EUT TEST SETUP PICTURE	10
FIGURE 2.	RADIATED EMISSIONS TEST SETUP DIAGRAM	12

TEST CONFIGURATION PHOTOGRAPHS

PHOTOGRAPH 1. KX160B, TRI MODE MOBILE CELLULAR PHONE (OPEN)	8
PHOTOGRAPH 2. KX160B, TRI MODE MOBILE CELLULAR PHONE (CLOSE	D)9
PHOTOGRAPH 3. FCC, PART 22/24 RADIATED EMISSIONS TEST CONFIGUR	ATION20
PHOTOGRAPH 4. FCC, PART 22/24 RADIATED EMISSIONS TEST CONFIGUR	ATION21
PHOTOGRAPH 5. FCC, PART 22/24 RADIATED EMISSIONS TEST CONFIGUR	ATION

APPENDICES

A. RADIATED EMISSIONS MEASUREMENT UNCERTAINTIES	23
B. NEMKO USA, INC.'S TEST EQUIPMENT & FACILITIES CALIBRATION PROGRAM	25

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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	3 of31

EMC Test Report

For

Kyocera Wireless Corp.

Test Number	: 25-713-KYO
Product Name	: TRI-MODE CELLULAR MOBILE PHONE
Regulation	: FCC, Part 22, Subpart H, Part 24, Subpart E : Industry Canada, RSS-129, RSS-133
Date Report Reviewed Accepted by:	: September 12, 2005
Recepted by:	Kyocera Wireless Corp.
	10300 Campus Point Drive
	San Diego, CA 92121
	Phone: 858 882-2879
	Fax: 858 882-2010
	F P Flum
Report Issued By:	<u> </u>

F. R. Fluery, Frontline Manager

Mikel 7. 20

Tested By:

Mike Krumweide, EMC Test Engineer

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DATE	DATE DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	4 of31

Administrative Data

Level

Regulation	: FCC, Part 22, Subpart H, Part 24, Subpart E
	: Industry Canada, RSS-129, RSS-133

: Not Applicable

Test Method	: ANSI C63.4 – 2003
	: CSA C108 M1983
	: TIA/EIA 603B

Test Type	: Certification
Manufacturer	: Kyocera Wireless Corp.
EUT Type/:Model #	: KX160B
Date(s) of Test	: August 16, 2005 to August 18, 2005
Customer Personnel	: John Turner, Engineer
Nemko Personnel	: Mike Krumweide, EMC Test Engineer
	:
Test Location	: OPEN Area Test Site
	Nemko USA, Inc.
	11696 Sorrento Valley Road, Suite F
	San Diego, CA 92121

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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	5 of31

EUT Description

The KX160B is a TRI-MODE CELLULAR MOBILE PHONE with Bluetooth capabilities. Its function is to provide communication for mobile phone users. The EUT was placed into FM Transmit, PCS Transmit and CDMA Transmit modes on High, Mid and Low channels for fundamental and harmonics emissions measurements.

	DEVICE		MANUFACTURER MODEL # SERIAL #	POWER CABLE
EUT - T	RI-MODE	CELLULAR	Kyocera Wireless Corp.	N/A
MOBI	LE PHONE		Model: KX160B	
			SN: A1DX1CSC0X	

CONNECTION	I/O CABLE
None	

REASON FOR TEST

The EUT was tested to qualify for FCC Part 22 and Part 24, and RSS-133.

CHANGES MADE DURING TEST

The following design modifications were made to the EUT during testing.

No design modifications were made to the EUT during testing.

DEVIATIONS FROM STANDARD TEST METHOD

-- None

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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	6 of31

CERTIFICATION AND TEST SUMMARY

Test Type	In Accordance with	Frequency Range	EUT
	Document	Investigated	Complies
Radiated Spurious Emissions	FCC, Part 22, Subpart H, Part 24, Subpart E Industry Canada, RSS-129, RSS-133	824 – 19990 MHz	PASS

The TRI-MODE CELLULAR MOBILE PHONE complied with FCC Part 15.109, Part 15.209, Part 22 and Part 24; Industry Canada, RSS129 and RSS-133 when tested in the system configuration defined herein.

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810		
DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	7 of31

1. DESCRIPTION OF TEST SITE AND EQUIPMENT

1.1. Description of Test Site

The test site is located at 11696 Sorrento Valley Road, Suite F, San Diego, CA 92121. The site is physically located 18 miles Northwest of downtown San Diego. The general area is a valley 1.5 miles east of the Pacific Ocean. This particular part of the valley tends to minimize ambient levels, i.e. radio and TV broadcast stations and land mobile communications. The three and ten-meter Open Area Test Site (OATS) is located behind the office/lab building. It conforms to the normalized site attenuation limits and construction specifications as set in the EN 55022 (1998), CISPR 16 (2000) and 22 (1997) and ANSI C63.4 (2003) documents. The OATS normalized site attenuation characteristics are verified for compliance every.

DESCRIPTION OF TESTING METHODS

1.2. Introduction

As required in 47 CFR, Parts 2 and 15, the methods employed to test the radiated and conducted emissions (as applicable) of the EUT are those contained within the American National Standards Institute document ANSI C63.4 (2003), titled "Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz." All applicable FCC Rule Sections that provide further guidance for performance of such testing are also observed.

For General Test Configuration please refer to Figure 1 on the following page.

Digital devices sold in Canada are required to comply with the Interference Causing Equipment Standard for Digital Apparatus, ICES-003. These test methods and limits are specified in the Canadian Standards Association's (CSA) Standard C108.8-M1983 (1-1-94 version) and are "essentially equivalent" with FCC, Part 15 and CISPR 22 (EN55022) rules for unintentional radiators per EMCAB-3, Issue 3 (May 1998). No further testing is required for compliance to ICES-003.

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810		
DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	8 of31

Photograph 1. KX160B, Tri Mode Mobile Cellular Phone (Open)



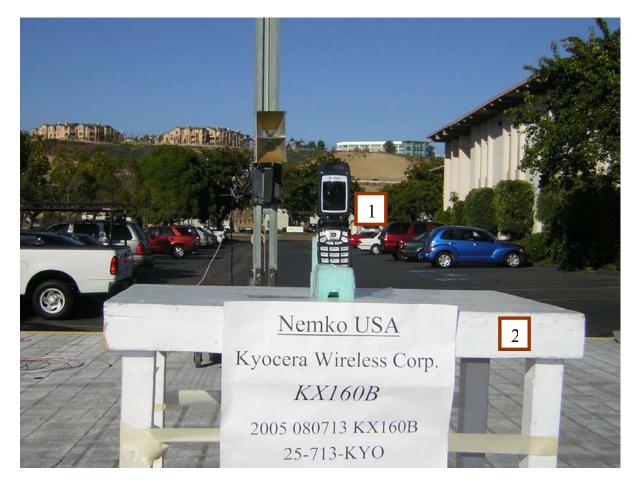
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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	9 of31

Photograph 2. KX160B, Tri Mode Mobile Cellular Phone (Closed)



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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	10 of31

Figure 1. General EUT Test Setup Picture



CONFIGURATION LEGEND

- 1. EUT: TRI-MODE CELLULAR MOBILE PHONE (Open mode shown)
- 2. 80cm Non-Conductive Support Table

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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	11 of31

1.3. Configuration and Methods of Measurements for Radiated Emissions

Section 8 of ANSI C63.4 determines the general configuration and procedures for measuring the radiated emissions of equipment under test. Initially, the primary emission frequencies are identified inside the test lab by positioning a broadband receive antenna one meter from the EUT to locate frequencies of significant radiation. Next, the EUT and associated system are placed on a turntable on a ten meter open area test site (registered with the FCC in accord with its Rules and ANSI C63.4) and the receive antenna is located at a distance of ten meters from the EUT.

The EUT and associated system are configured to operate continuously, representing a "normally operating" mode. All significant radiated emissions are recorded when maximum radiation on each frequency is observed, in accordance with part 8 of ANSI C63.4 and Section 15.33 of the FCC Rules. To ensure that the maximum emission at each discrete frequency of interest is observed, the receive antenna is varied in height from one to four meters and rotated to horizontal and vertical polarities, and the turntable is also rotated to determine the worst emitting configuration. The numerical results of the test are included herein to demonstrate compliance.

The numerical results that are applied to the emissions limits are arrived at by the following method:

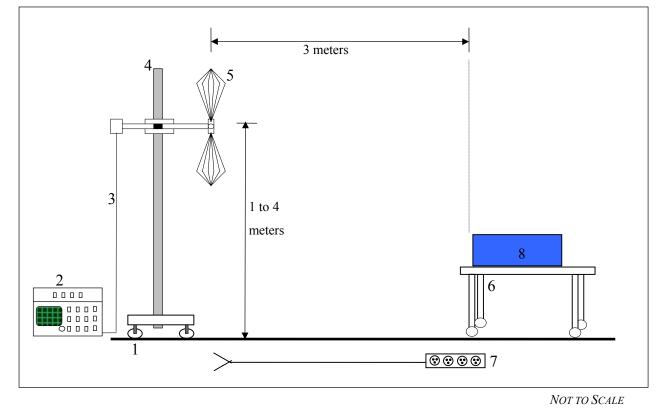
Example: A=RR+CL+AF A = Amplitude dBuV/M RR = Receiver Reading dBuV CL = cable loss dB AF = antenna factor dBm-1 Example Frequency = 110MHz 18.5 dBuV (spectrum analyzer reading) <u>+3.0 dB</u> (cable loss @ frequency) 21.5 dBuV <u>+15.4 dBm-1</u> (antenna factor @ frequency) 36.9 dBuV/M Final adjusted value

The final adjusted value is then compared to the appropriate emission limit to determine compliance.

For Radiated Emissions Test Configuration please refer to Figure 4 on the following page.

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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	12 of31





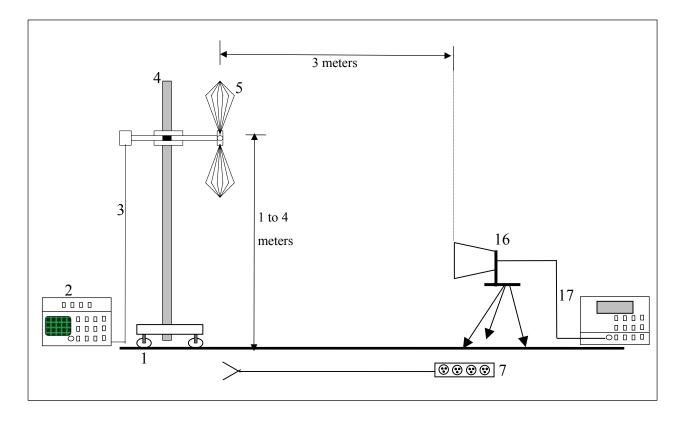
CONFIGURATION LEGEND

- 1. Ground plane (11 X 17 meters)
- 2. Spectrum Analyzer with Quasi-Peak Adapter
- 3. Coax interconnect from Receive Antenna to Spectrum Analyzer
- 4. Antenna Mast with motorized mounting assembly
- 5. Receive Antenna (basic relative position)
- 6. Non-Conducting table 80 cm above ground plane
- 7. AC power for devices
- 8. EUT: TRI-MODE CELLULAR MOBILE PHONE

Fundamental transmit frequencies were tested on 3 orthogonal axes to determine maximum amplitude position. This worst-case axis was then used to measure harmonics and recorded. Test setup pictures of these axes are found further in this report.

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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	13 of31

Figure 3. Substitution Method Test Setup Diagram



NOT TO SCALE

CONFIGURATION LEGEND

- 9. Ground plane (11 X 17 meters)
- 10. Spectrum Analyzer with Quasi-Peak Adapter
- 11. Coax interconnect from Receive Antenna to Spectrum Analyzer
- 12. Antenna Mast with motorized mounting assembly
- 13. Receive Antenna (basic relative position)
- 14. Non-Conducting table 80 cm above ground plane
- 15. AC power for devices
- 16. Radiating Horn Antenna
- 17. Signal Generator

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DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	14 of31

2. Test Results

2.1. Radiated Emissions Test Data

FCC Part 2, 22 & 24 Emissions Substitution

1) Methodology Used: TIA/EIA603 (see attached excerpt).

2) The Substitution Method is used for fundamental power levels and spurious emissions when RF emission signals are measured within 20 dB of the limit.

3) Formula Used to calculate the values:

a) Measured value + antenna factor + cable loss - preamplifier = Max Level
b) Margin = Max level - Limit
c) Signal Generator power level - cable loss + antenna gain = ERP Part 22 or EIRP Part 24
d) Substituted Margin = ERP (or EIRP) - Limit *Note: gain for dipole = 0; antenna factor is not the same as antenna gain*

Note: The signal generator power level is the power required when transmitting into the substituting antenna to duplicate the Measured Value. Substituted margin is reported in 731 forms pertaining to certification grants and Class II Permissive Changes when a direct conducted power reading cannot be performed.

Note: Per FCC Part 2:1051 the FCC does not require reporting of Spurious Emissions when they are more than 20dB below the permissible limit, therefore no signal substitution measurements will be performed on these signals.

Nemko USA,	Inc.	11696 Sorrento Valley Road, Suite F, San Diego, CA 9212 Phone (858) 755-5525 Fax (858) 452-181				
DATE	DOCUMENT N	AME	DOCUMENT #	PAGE		
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	15 of31		

				F	Radiated Emissio	ns Data				
							Job # :		-KYO 1	
lient Name		Kyocera-Wi	reless							
UT Name :		Cellular Pho								
UT Model #	#:	KX160B								
UT Serial #	ŧ:	A1DX1C								
UT Config.	:	FM TX Harr	nonics							
pecification	n:	FCC Part 22	2				Refere	ence :		
Rod. Ant. #:				Temp. (°C) :	18					08/25/05
Sicon Ant.#:				Humidity (%) :	68					Mike Krumweide
og Ant.#:		112		EUT Voltage :	NA			eak Ban		
RG Ant. #		752		EUT Frequency			V	ideo Bai	ndwidth	1 MHz
ipole Ant.#	:	758		Phase:	NA	0.04				
able#:		40ft		Location:	<u>RN # 32955</u>	0-01				
Preamp#:		842		Distance:	n factor 7					
spec An.#:		835		ERP conversior						
Meas.	Vertical	Horizontal		Max Level	Spec. Limit (ERP)	Margin	EUT	Ant.	Pass	
Freq.	(dBuV)	(dBuV)	CF (db)	(dBm)	(dBm)	dB	Rotation	Height	Fail	
(MHz)	pk	pk		pk	pk	pk			Unc.	Comment
1648.08	64.0	57.6	-19.5	-52.8	-13.0	-39.8			Pass	*
2472.12	71.3	63.8	-15.7	-41.7	-13.0	-28.7			Pass	*
3296.16	60.7	57.6	-10.2	-46.8	-13.0	-33.8			Pass	*
4120.20	51.4	51.1	-5.4	-51.2	-13.0	-38.2			Pass	*
4944.24			-5.4		-13.0					NF
5768.28			-1.3		-13.0					NF
6592.32			0.6		-13.0					NF
7416.36			3.7		-13.0		_			NF
8240.40 9064.44			7.0 10.3		-13.0 -13.0					NF NF
9004.44			10.5		-13.0		-			
1672.98	55.4	53.4	-19.5	-61.4	-13.0	-48.4			Pass	*
2509.47	65.1	66.7	-15.4	-46.0	-13.0	-33.0			Pass	*
3345.96	58.7	57.0	-10.2	-48.8	-13.0	-35.8			Pass	*
4182.45			-5.4		-13.0					NF
5018.94			-1.5		-13.0					NF
5855.43		ļ	-1.3		-13.0				<u> </u>	NF
6691.92			0.6		-13.0		_			NF
7528.41			3.9		-13.0					NF
8364.90 9201.39			7.0 10.3		-13.0 -13.0					NF
3201.38			10.5		-13.0					
1697.94	56.6	53.5	-19.5	-60.2	-13.0	-47.2			Pass	*
2546.91	66.5	68.5	-15.4	-44.2	-13.0	-31.2			Pass	*
3395.88	58.9	56.5	-10.2	-48.6	-13.0	-35.6			Pass	*
4244.85			-5.4		-13.0					NF
5093.82			-1.5		-13.0					NF
5942.79			-1.3		-13.0					NF
6791.76			0.6		-13.0					NF
7640.73			3.9		-13.0					NF
8489.70 9338.67			7.0		-13.0					NF
		1	10.3	1	-13.0		1	1		1

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DATE	DOCUMENT N	AME	DOCUMENT #	PAGE		
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	16 of31		

				F	Radiated Emission	ons Data				
							Job # :	25-713- Page		Test # :22
								гауе		
Client Name		Kyocera-Wi								
EUT Name		Cellular Pho	one							
EUT Model EUT Serial :		KX160B	SCOV							
EUT Serial		A1DX1C CDMA TX F		<u></u>						
	• •	CDIMATAT	lamonic	>						
Specificatio		FCC Part 22					Refere	nce :		
Rod. Ant. #:		0		Temp. (°C) :	18					08/25/05
Bicon Ant.#		0		Humidity (%) :	68					Mike Krumweide
Log Ant.#:		112		EUT Voltage :	NA			eak Ban		
DRG Ant. #		752		EUT Frequency			V	ideo Bar	ndwidth	1 MHz
Dipole Ant.#	н.	758		Phase:	NA	E0.01				
Cable#:		40ft		Location:	RN # 3295	00-01				
Preamp#: Spec An.#:		<u>842</u> 835		Distance: ERP conversior	n factor 7					
Spec An.#.		630		ERP conversion						
Meas.	Vertical	Horizontal		Max Level	Spec. Limit (ERP)	Margin	EUT	Ant.	Pass	
Freq.	(dBuV)	(dBuV)	CF (db)	(dBm)	(dBm)	dB	Rotation	Height	Fail	
(MHz)	pk	pk		pk	pk	pk			Unc.	Comment
1649.40	59.8	56.2	-19.54	-57.0	-13.0	-44.0	_		Pass	*
2474.10	72.2	69.8	-19.54	-40.8	-13.0	-44.0			Pass	*
3298.80	62.3	59.3	-10.24	-45.2	-13.0	-32.2			Pass	*
4123.50	02.5	55.5	-5.352	-40.2	-13.0	-02.2			1 433	NF
4948.20			-5.352		-13.0					NF
5772.90			-1.271		-13.0					NF
6597.60			0.5822		-13.0					NF
7422.30			3.7067		-13.0					NF
8247.00			6.9678		-13.0					NF
9071.7			10.299		-13.0					
4070.00	00.4	50.4	10.54	50.4	40.0	40.4				*
1672.98	63.4	56.4	-19.54	-53.4	-13.0	-40.4	_		Pass	*
2509.47 3345.96	75.3 57.6	76.2 55.2	-15.4 -10.24	-36.5 -49.9	-13.0 -13.0	-23.5 -36.9			Pass	*
4182.45	0.10	<u> </u>	-10.24	-49.9	-13.0	-30.9			Pass	" NF
5018.94		<u> </u>	-5.352		-13.0					NF
5855.43		<u> </u>	-1.471		-13.0					NF
6691.92		<u> </u>	0.5822		-13.0					NF
7528.41		1	3.9067		-13.0					NF
8364.90		1	6.9678		-13.0					NF
9201.39			10.299		-13.0					
1600.00	E7 7	54.0	10.54	E0.4	10.0	40.4			Derr	*
1696.62 2544.93	57.7 77.1	54.0 78.0	-19.54 -15.4	-59.1 -34.7	-13.0 -13.0	-46.1 -21.7			Pass	*
3393.24	59.1	57.3	-15.4	-34.7 -48.4	-13.0	-21.7 -35.4			Pass	*
4241.55	59.1	57.5	-5.352	-40.4	-13.0	-30.4			Pass	NF
5089.86			-5.352		-13.0					NF
5938.17		<u> </u>	-1.471		-13.0					NF
6786.48		<u> </u>	0.5822		-13.0					NF
7634.79		<u> </u>	3.9067		-13.0					NF
		1							ļ	
8483.10			6.9678		-13.0					NF

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DATE	DOCUMENT N	AME	DOCUMENT #	PAGE		
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	17 of31		

				F	Radiated Emissic	ons Data				
							Job # :	25-713 Page		Test # :333
Client Name	۰.	Kyocera-Wir	eless							
EUT Name :		Cellular Pho								
EUT Model		KX160B								
EUT Serial #		A1DX1C	SC0X							
EUT Config.	:	PCS TX Har								
Specificatior	ו:	FCC Part 24	ŀ				Refere	ence :		
Rod. Ant. #:		0		Temp. (°C) :	18				Date :	08/25/05
Bicon Ant.#:		0		Humidity (%) :	68				Staff :	Mike Krumweide
_og Ant.#:		112		EUT Voltage :	NA		P	eak Ban	dwidth:	1 MHz
DRG Ant. #		752 625		EUT Frequency			V	ideo Bai	ndwidth	1 MHz
Dipole Ant.#	:	758		Phase:	NA					
Cable#:		40ft		Location:	<u>RN # 3295</u>	50-01				
Preamp#:		842		Distance:	<u>3m</u>					
Spec An.#:		835		EIRP conversio	n factor 5.5					
Meas.	Vertical	Horizontal		Max Level	Spec. Limit (ERIP)	Margin	EUT	Ant.	Pass	
Freq.	(dBuV)	(dBuV)	CF (db)	(dBm)	(dBm)	dB	Rotation	Height	Fail	
(MHz)	pk	pk		pk	pk	pk			Unc.	Comment
			┥ ┥							
3702.50	33.3	31.0	36.7	-25.3	-13.0	-12.3			Pass	* NO PREAMP
5553.75	62.7	61.6	-1.3	-33.8	-13.0	-20.8			Pass	*
7405.00	52.4	53.3	3.7	-38.3	-13.0	-25.3			Pass	*
9256.25	49.3	47.3	10.3	-35.7	-13.0	-22.7			Pass	*
11107.50			15.1		-13.0					NF
12958.75			16.6		-13.0					NF
14810.00			21.5		-13.0					NF
16661.25			23.9		-13.0					NF
18512.50 20363.75			37.8 38.5		-13.0 -13.0					NF NF
20303.75			38.5		-13.0					
3760.00	28.2	27.0	36.7	-30.4	-13.0	-17.4			Pass	* NO PREAMP
5640.00	61.2	61.7	-1.3	-34.8	-13.0	-21.8			Pass	*
7520.00	50.4	52.1	3.9	-39.3	-13.0	-26.3			Pass	*
9400.00	48.4	47.8	10.3	-36.6	-13.0	-23.6			Pass	*
11280.00			15.1		-13.0					NF
13160.00			20.4		-13.0					NF
15040.00			21.3		-13.0					NF
16920.00			23.9		-13.0					NF
18800.00			37.9		-13.0					NF
20690			38.6		-13.0					NF
3817.50	60.0	57.0	-9.1	-44.4	-13.0	-31.4			Pass	*
5726.25	57.0	58.4	-1.3	-44.4 -38.1	-13.0	-25.1			Pass	*
7635.00	49.9	49.7	3.9	-41.5	-13.0	-28.5			Pass	*
9543.75	47.2	47.4	10.2	-37.7	-13.0	-24.7			Pass	*
11452.50		1	15.1		-13.0	2				NF
13361.25			20.4		-13.0				1	NF
15270.00			21.3		-13.0				Ì	NF
17178.75			31.0		-13.0					NF
			38.0		-13.0					NF
19087.50 20996.25			39.1		-13.0					NF

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DATE	DOCUMENT N	AME	DOCUMENT #	PAGE		
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	18 of 31		

2.2. Substitution Method Test Data

	Substitution Method For Radiated Emissions							
Complete		Yes			Job # :	25-713-KYO	Test # :	1
Preliminary					Page		of	1
Client Name : EUT Name : EUT Model # : EUT Part # :		KYOCERA Cellular Pho KX160B	WIRELESS Corp).				
EUT Fait # :		A1DX1C	SC0X					
EUT Config. :		Transmit						
Specification :		FCC Part 22	2 & Part 24			Reference :		
			Temp. (deg. C) :			Date :	09/01/05	-
Dipole Ant.#:		760	Humidity (%) :			Time : Staff :	Miko Krum	woido
Log Ant.#: DRG Ant. # RX		<u>110</u> 752	EUT Voltage : EUT Freq :			Photo ID:	Mike Krum	weide
DRG Ant. # TX		529	Phase:	-	Pe	ak Bandwidth:	RBW-1MH	_
Cable#: TX		40ft	Location:	•	1.00	an Banawiath.	VBW-1MH	
Cable#: RX		60ft	Distance:	-				
Spec An.#:		835		•				
QP #:		NA						
PreSelect#:		NA						
	Р	CS Harmoni						
targe		Horn	cable	Signal	Total	Spec	Margin	
Frequency	level	Gain	loss	Generator	(EIRP)			
mHz	dBuV/m	dBi	dB	dBm	dBm	dBm	dBm	4
3702.50	33.3	9.87	7.5	-31.00	-28.63	-13	-15.6	1 MHz
3760.00	28.2	9.88	7.6	-37.00	-34.72	-13	-21.7	1 MHz

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DATE	DOCUMENT N	AME	DOCUMENT #	PAGE		
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	19 of31		

RADIATED EMISSIONS AND SUBSTITUTION METHOD

TEST EQUIPMENT

Client	Kyocera-Wireless		EU	T Name	TRI-MODE CELLULAR MOBILE PHONE				
PAN #	25-713-KYO		EU	EUT Model KX160B					
Device T	Model	#	Asset #	Used	Cal Done	Cal Due			
Pre-Am	plifier			1					
High-Fre	Nemko)	842	X	5/19/05	5/19/06			
Antenna									
Antenna,	Ridged Guide	3115		752	X	12/29/04	12/29/05		
Antenna,	Ridged Guide	3115		529	Х	4/13/05	4/13/06		
Spectru	m Analyzer / Recei	iver		1					
Spectrum Analyzer, R&S R		RHDFS	EK	835	Х	12/30/04	12/30/05		
Signal Ge	enerator, Gigatronics	1018		440	X	9/22/04	9/22/05		

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DATE	DOCUMENT N	AME	DOCUMENT #	PAGE		
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	20 of31		

Photograph 3. FCC, Part 22/24 Radiated Emissions Test Configuration

EUT IN "VERTICAL" POSITION



Nemko USA,	Inc.	11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810				
DATE	DOCUMENT N	AME	DOCUMENT #	PAGE		
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	21 of31		

Photograph 4. FCC, Part 22/24 Radiated Emissions Test Configuration EUT IN "ON-SIDE" POSITION



Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810		
DATE	DOCUMENT N	AME	DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	22 of31

Photograph 5. FCC, Part 22/24 Radiated Emissions Test Configuration EUT IN "FACE-UP" POSITION



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DATE	DOCUMENT N	AME	DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	23 of31

APPENDIX A

A. Radiated Emissions Measurement Uncertainties

1. Introduction

ISO/IEC 17025:1999 and ANSI/NCSL Z540-1-1994 require that all measurements contained in a test report be "traceable". "Traceability" is defined in the *International Vocabulary of Basic and General Terms in Metrology* (ISO: 1993) as: "the property of the result of a measurement... whereby it can be related to stated references, usually national or international standards, through an unbroken chain of comparisons, *all having stated uncertainties*".

The purposes of this Appendix are to "state the *Measurement Uncertainties*" of the conducted emissions and radiated emissions measurements contained in Section 5 of this Test Report, and to provide a practical explanation of the meaning of these measurement uncertainties.

2. Statement of the Worst-Case Measurement Uncertainties for the Conducted and Radiated Emissions Measurements Contained in This Test Report

1 0		0
Radiated Emissions Measurement Detection Systems	Applicable Frequency Range	"U" for a k=2 Coverage Factor
HP8568B Spectrum Analyzer with QPA & HP8447F Preamplifier	30 MHz - 200 MHz	+4.0 dB, -4.1 dB
HP8568B Spectrum Analyzer with QPA & HP8447F Preamplifier	200 MHz-1000 MHz	+/- 3.5 dB
HP8566B Spectrum Analyzer with QPA & Preselector	30 MHz - 200 MHz	+3.9 dB, -4.0 dB
HP8566B Spectrum Analyzer with QPA & Preselector	200 MHz-1000 MHz	+/- 3.4 dB
HP8566B Spectrum Analyzer with QPA & HP 8449A Preamplifier	1 GHz - 18 GHz	+2.5 dB, -2.6 dB
HP8566B Spectrum Analyzer with QPA & HP8449A Preamplifier	18 GHz - 40 GHz	+/- 3.4 dB
NOTES:	•	

Table 1: Worst-Case Expanded Uncertainty "U" of Measurement for a k=2 Coverage Factor

1. Applies to 3 and 10 meter measurement distances

2. Applies to all valid combinations of Transducers (i.e. LISNs, Line Voltage Probes, and Antennas, as appropriate)

3. Excludes the Repeatability of the EUT

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DATE	DOCUMENT N	AME	DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	24 of31

3. Practical Explanation of the Meaning of Radiated Emissions Measurement Uncertainties

In general, a "Statement of Measurement Uncertainty" means that with a certain (specified) confidence level, the "true" value of a measurand will be between a (stated) upper bound and a (stated) lower bound.

In the specific case of EMC Measurements in this test report, the measurement uncertainties of the conducted emissions measurements and the radiated emissions measurements have been calculated in accordance with the method detailed in the following documents:

- o ANSI Z540.2 (2002) Guide to the Expression of Uncertainty in Measurement
- o NIS 81:1994, The Treatment of Uncertainty in EMC Measurements (NAMAS, 1994)
- NIST Technical Note 1297(1994), Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results (NIST, 1994)

The calculation method used in these documents requires that the stated uncertainty of the measurements be expressed as *an "expanded uncertainty"*, *U*, *with a k=2 coverage factor*. The practical interpretation of this method of expressing measurement uncertainty is shown in the following example:

EXAMPLE: Assume that at 39.51 MHz, the (measured) radiated emissions level was equal to +26.5 dBuV/m, and that the +/-2 standard deviations (i.e. 95% confidence level) measurement uncertainty was +/-3.4 dB.

In the example above, the phrase "k = 2 Coverage Factor" simply means that the measurement uncertainty is stated to cover +/-2 standard deviations (i.e. a 95% confidence interval) about the measurand. The measurand is the radiated emissions measurement of +26.5 dBuV/m at 39.51 MHz, and the 95% bounds for the uncertainty are -3.4 dB to + 3.4 dB. One can thus be 95% confident that the "true" value of the radiated emissions measurement is between +23.1 dBuV/m and +29.5 dBuV/m. *In effect, this means that in the above example there is only a 2.5% chance that the "true" radiated emissions value exceeds +29.5 dBuV/m.*

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810		/
DATE	DOCUMENT NAME		DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	25 of31

APPENDIX B

B. Nemko USA, Inc.'s Test Equipment & Facilities Calibration Program

Nemko USA, Inc. operates a comprehensive Periodic Calibration Program in order to ensure the validity of all test data. Nemko USA's Periodic Calibration Program is fully compliant to the requirements of NVLAP Policy Guide PG-1-1988, ANSI/NCSL Z540-1-1994, ISO 10012:2003, ISO/IEC 17025:1999, and ISO-9000:2000. Nemko USA, Inc.'s calibrations program therefore meets or exceed the US national commercial and military requirements [N.B. ANSI/NCSL Z540-1-1994 replaces MIL-STD-45662A].

Specifically, all of Nemko USA's *primary reference standard devices* (e.g. vector voltmeters, multimeters, attenuators and terminations, RF power meters and their detector heads, oscilloscope mainframes and plug-ins, spectrum analyzers, RF preselectors, quasi-peak adapters, interference analyzers, impulse generators, signal generators and pulse/function generators, field-strength meters and their detector heads, etc.) and certain *secondary standard devices* (e.g. RF Preamplifiers used in CISPR 11/22 and FCC Part 15/18 tests) are periodically recalibrated by:

- A Nemko USA-approved independent (third party) metrology laboratory that uses NISTtraceable standards and that is ISO Guide 25-accredited as a calibration laboratories by NIST; or,
- A Nemko USA-approved independent (third party) metrology laboratory that uses NISTtraceable standards and that is ISO Guide 25-accredited as a calibration laboratory by another accreditation body (such as A2LA) that is mutually recognized by NIST; or,
- A manufacturer of Measurement and Test Equipment (M&TE), if the manufacturer uses NISTtraceable standards and is ISO Guide 25-accredited as calibration laboratory either by NIST or by another accreditation body (such as A2LA) that is mutually recognized by NIST; or
- A manufacturer of M&TE (or by a Nemko USA-approved independent third party metrology laboratory) that is not ISO Guide 25-accredited. (In these cases, Nemko USA conducts an annual audit of the manufacturer or metrology laboratory for the purposes of proving traceability to NIST, ensuring that adequate and repeatable calibration procedures are being applied, and verifying conformity with the other requirements of ISO Guide 25).

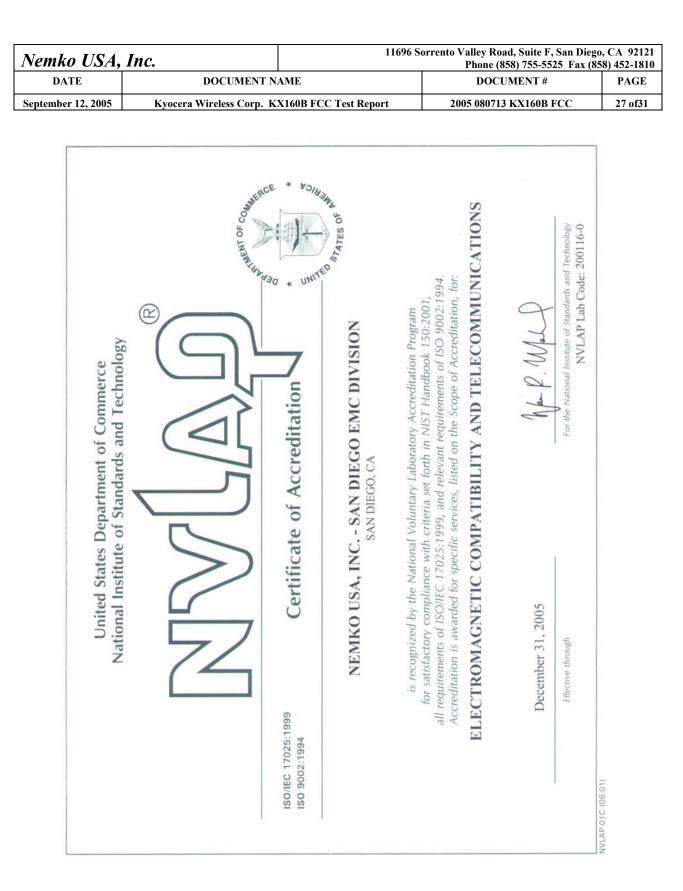
Nemko USA, Inc.		11696 S	orrento Valley Road, Suite F, San Diego Phone (858) 755-5525 Fax (85	/
DATE	DOCUMENT N	AME	DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	26 of31

In all cases, the entity performing the Calibration is required to furnish Nemko USA with a calibration test report and/or certificate of calibration, and a "calibration sticker" on each item of M&TE that is successfully calibrated.

Calibration intervals are normally one year, except when the manufacture advises a shorter interval (e.g. the HP 8568B Spectrum Analyzer is recalibrated every six months) or if US Government directives or client requirements demand a shorter interval. Items of instrumentation/related equipment which fail during routine use, or which suffer visible mechanical damage (during use or while in transit), are sidelined pending repair and recalibration. (Repairs are carried out either in-house [if minor] or by a Nemko USA-approved independent [third party] metrology laboratory, or by the manufacturer of the item of M&TE).

Each antenna used for CISPR 11 and CISPR 22 and FCC Part 15 and Part 18 radiated emissions testing (and for testing to the equivalent European Norms) is calibrated annually by either a NIST (or A2LA) ISO Standard 17025-Accredited third-party Antenna Calibration Laboratory or by the antenna's OEM if the OEM is NIST or A2LA ISO Standard 17025-accredited as an antenna calibration laboratory. The antenna calibrations are performed using the methods specified in Annex G.5 of CISPR 16-1(2003) or ANSI C63.5-2004, including the "Three-Antenna Method". Certain other kinds of antennas (e.g. magnetic-shielded loop antennas) are calibrated annually by either a NIST (or A2LA) ISO Standard 17025-accredited third-party antenna calibration laboratory, or by the antenna's OEM if the OEM is NIST or A2LA ISO Standard 17025-accredited as an antenna calibration laboratory antenna calibration laboratory or by the antenna's OEM if the OEM is NIST or A2LA ISO Standard 17025-accredited as an antenna calibration laboratory antenna calibration laboratory or by the antenna's OEM if the OEM is NIST or A2LA ISO Standard 17025-accredited as an antenna calibration laboratory or by the antenna's OEM if the OEM is NIST or A2LA ISO Standard 17025-accredited as an antenna calibration laboratory using the procedures specified in the latest version of SAE ARP-958.

In accordance with FCC and other regulations, Nemko USA recalibrates its suite of antennas used for radiated emissions tests on an annual basis. These calibrations are performed as a precursor to the FCC-required annual revalidation of the Normalized Site Attenuation properties of Nemko USA's Open Area Test Site. Nemko USA, Inc. uses the procedures given in both Subclause 16.6 and Annex G.2 of CISPR 16-1 (2003), and, ANSI C63.4-2003 when performing the normalized site attenuation measurements.



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DATE	DOCUMENT N	AME	DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	28 of31



SCOPE OF ACCREDITATION TO ISO/IEC 17025:1999

Nemko USA, Inc. - San Diego EMC Division 11696 Sorrento Valley Road, Suite F San Diego, CA 92121 Mr. Ricky Hill Phone: 858-755-5525 x207 Fax: 858-793-9914 E-Mail: rick.hill@nemko.com URL: http://www.nemko.com

Revised Scope 06/22/2005 ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NVLAP LAB CODE 200116-0

NVLAP Code Designation / Description

Emissions Test Methods:

12/CIS14	CISPR 14-1 (March 30, 2000): Limits and Methods of Measurement of Radio interference Characteristics of Household Electrical Appliances, Portable Tools and Similiar Electrical Apparatus - Part 1: Emissions
12/CIS14a	EN 55014-1 (1993), A1 (1997), A2 (1999):
12/CIS14b	AS/NZS 1044 (1995):
12/CIS14c	CNS 13783-1: Electromagnetic Compatibility Requirements for household appliances, electric tools and similar apparatus - Part 1: Emissions
12/CIS15b	CNS 13439 (2000) + A1 (2001): Limits and methods of measurement of radio disturbance characteristics of electrical lighting and similar equipment
12/CIS22	IEC/CISPR 22 (1997) & EN 55022 (1998) + A1(2000): Limits and methods of measurement of radio disturbance characteristics of information technology equipment
12/CIS22a	IEC/CISPR 22 (1993) and EN 55022 (1994): Limits and methods of measurement of radio disturbance characteristics of information technology equipment, Amendment 1 (1995) and Amendment 2 (1996)
12/CIS22b	CNS 13438 (1997): Limits and Methods of Measurement of Radio Interference

CIS22b CNS 13438 (1997): Limits and Methods of Measurement of Radio Interfere Characteristics of Information Technology Equipment

2005-01-01 through 2005-12-31 Effective dates

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Page 1 of 4

NVLAP-01S (REV. 2005-05-19)

Nombo INA Inc		orrento Valley Road, Suite F, San Diego Phone (858) 755-5525 Fax (85	,	
DATE	DOCUMENT N	AME	DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	29 of31



Revised Scope 06/22/2005 ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NVLAP LAB CODE 200116-0

HOD TELECC	
NVLAP Code	Designation / Description
12/EM02a	IEC 61000-3-2, Edition 2.1 (2001-10), EN 61000-3-2 (2000), and AS/NZS 2279.1 (2000): Electromagnetic compatibility (EMC) Part 3-2: Limits - Limits for harmonic current emissions (equipment input current <= 16 A)
12/EM03b	IEC 61000-3-3, Edition 1.1(2002-03) & EN 61000-3-3, A1(2001): EMC - Part 3-3: Limits - Limitations of voltage changes, voltage flucuations and flicker, in public low-voltage supply-systems, for equipment with rated current <=16 A per phase and not subject to conditional connections
12/F18	FCC OST/MP-5 (1986): FCC Methods of Measurement of Radio Noise Emissions for ISM Equipment (cited in FCC Method 47 CFR Part 18 - Industrial, Scientific, and Medical Equipment)
12/T51	AS/NZS CISPR 22 (2002) and AS/NZS 3548 (1997): Electromagnetic Interference - Limits and Methods of Measurement of Information Technology Equipment
Immunity Test I	Methods:
12/I01	IEC 61000-4-2, Ed. 1.2 (2001) + A1, A2; EN 61000-4-2: Electrostatic Discharge Immunity Test
12/I02	IEC 61000-4-3, Ed. 2.0 (2002-03); EN 61000-4-3 (2002): Radiated Radio-Frequency Electromagnetic Field Immunity Test
12/I03	IEC 61000-4-4(1995), A1(2000), A2(2001); EN 61000-4-4: Electromagnetic compatibility (EMC) - Part 4-4: Testing and measurement techniques - Electrical Fast Transient/Burst Immunity Test
12/I04	IEC 61000-4-5, Ed. 1.1 (2001-04); EN 61000-4-5: Electromagnetic compatibility (EMC) - Part 4-5: Testing and measurement techniques - Surge immunity test
12/I05	IEC 61000-4-6, Ed. 2.0 (2003-05); EN 61000-4-6: Electromagnetic compatibility (EMC) - Part 4-6: Testing and measurement techniques - Immunity to conducted disturbances, induced by radio-frequency fields
12/I06	IEC 61000-4-8, Ed. 1.1 (2001); EN 61000-4-8: Electromagnetic compatibility (EMC) - Part 4-8: Testing and measurement techniques - Power frequency magnetic field immunity test

2005-01-01 through 2005-12-31 Effective dates

stitute of Standards and Technology For the Nation

Page 2 of 4

NVLAP-01S (REV. 2005-05-19)

Nemko USA, Inc.		11696 S	orrento Valley Road, Suite F, San Diego Phone (858) 755-5525 Fax (85	/
DATE	DOCUMENT N	AME	DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. K	X160B FCC Test Report	2005 080713 KX160B FCC	30 of31



Revised Scope 06/22/2005 ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NVLAP LAB CODE 200116-0

NVLAP Code	Designation / Description
12/I07	IEC 61000-4-11, Ed. 1.1 (2001-03); EN 61000-4-11: Voltage Dips, Short Interruptions and Voltage Variations Immunity Tests
MIL-STD-462 :	Conducted Emissions:
12/A13	MIL-STD-462 Version D Method CE101
12/A14	MIL-STD-462 Version D Method CE102
12/A15	MIL-STD-462 Version D Method CE106
12/A16	MIL-STD-461 Version E Method CE101
12/A17	MIL-STD-461 Version E Method CE102
12/A18	MIL-STD-461 Version E Method CE106
MIL-STD-462 :	Conducted Susceptibility:
12/B12	MIL-STD-462 Version D Method CS101
12/B13	MIL-STD-462 Version D Method CS103
12/B14	MIL-STD-462 Version D Method CS104
12/B15	MIL-STD-462 Version D Method CS105
12/B16	MIL-STD-462 Version D Method CS109
12/B17	MIL-STD-462 Version D Method CS114
12/B18	MIL-STD-462 Version D Method CS115
12/B19	MIL-STD-462 Version D Method CS116
12/B20	MIL-STD-461 Version E Method CS101
12/B21	MIL-STD-461 Version E Method CS103
12/B22	MIL-STD-461 Version E Method CS104

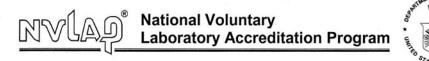
2005-01-01 through 2005-12-31 Effective dates

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NVLAP-01S (REV. 2005-05-19)

Page 3 of 4

Nemko USA, Inc.		11696 Sorrento Valley Road, Suite F, San Diego, CA 92121 Phone (858) 755-5525 Fax (858) 452-1810		
DATE	DOCUMENT N	AME	DOCUMENT #	PAGE
September 12, 2005	Kyocera Wireless Corp. KX160B FCC Test Report		2005 080713 KX160B FCC	31 of31



Revised Scope 06/22/2005 ELECTROMAGNETIC COMPATIBILITY AND TELECOMMUNICATIONS

NVLAP Code	Designation / Description			
12/B23	MIL-STD-461 Version E Method CS105			
12/B24	MIL-STD-461 Version E Method CS109			
12/B25	MIL-STD-461 Version E Method CS114			
12/B26	MIL-STD-461 Version E Method CS115			
12/B27	MIL-STD-461 Version E Method CS116			
MIL-STD-462 : Radiated Emissions:				
12/D04	MIL-STD-462 Version D Method RE101			
12/D05	MIL-STD-462 Version D Method RE102			
12/D06	MIL-STD-462 Version D Method RE103			
12/D07	MIL-STD-461 Version E Method RE101			
12/D08	MIL-STD-461 Version E Method RE102			
12/D09	MIL-STD-461 Version E Method RE103			
MIL-STD-462 : Radiated Susceptibility:				
12/E08	MIL-STD-462 Version D Method RS101			
12/E09	MIL-STD-462 Version D Method RS103			
12/E10	MIL-STD-462 Version D Method RS105			
12/E11	MIL-STD-461 Version E Method RS101			
12/E12	MIL-STD-461 Version E Method RS103			

2005-01-01 through 2005-12-31

Effective dates

MIL-STD-461 Version E Method RS105

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NVLAP-01S (REV. 2005-05-19)

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Page 4 of 4

12/E13